

Notice of References Cited	Application/Control No. 09/839,697	Applicant(s)/Patent Under Reexamination LOWRANCE ET AL.	
	Examiner Tan Dean D. Nguyen	Art Unit 3689	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,461,699	10-1995	Arbabi et al.	706/21
*	C	US-5,953,707	09-1999	Huang et al.	705/10
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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